Metrology for astronomical instruments in optical interferometry

Ground and space based applications
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Very Large Telescope at Cerro Paranal
VLTI: Quick Facts

• Four 8m Unit Telescopes:
  – Max. Baseline 130 m => angular resolution: 1.5 - 30 milli arcsec

• Three 1.8m Auxiliary Telescopes
  – Baselines between 8m and 200m => max. angular resolution: 1-20 milli arcsec

• Excellent uv coverage due to interferometer lay-out

• Instruments:
  – MIDI: Mid IR Instrument (10 - 20 $\mu$m), Limiting Magnitude N~5
    Angular resolution 20 milli arcsec, Two beam design
  – AMBER: Near IR Instrument (1-2.5 $\mu$m), Limiting Magnitude K~14
    Angular resolution 4 milli arcsec, Three beam design (closure phase)
  – PRIMA: Phase Referenced Imaging for Microarcsecond Astrometry
    Dual Feed Mode for:
    - Observations of faint objects (K~20)
    - Imaging of faint objects (UTs and ATs)
    - Astrometry on ATs (10 micro arcsec)
VLTI metrology

• Delay Lines metrology:
  – Heterodyne laser interferometer over 130 m with 2.4nm path length sensing resolution
  – Optimal optical lay-out: laser beam follows same path as stellar light for most accurate optical stellar path length variations sensing

• Internal optical path metrology for PRIMA:
  – Total optical path (two telescope optical paths) ~ 400 - 500m, 5 nm accuracy for monitoring the difference optical path length of max. 60 mm.
VLTI Dual Feed System
Laser metrology for PRIMA

Phase-Referenced Imaging for Micro-arcsecond Astrometry
simultaneous observations of two stellar objects separated by max. 1 arcmin.

\[ \text{OPD}_s = B \cdot \Delta S + \Delta L \] for \( \text{OPD}_r = 0 \)

\( B \): distance between the two telescopes
\( \Delta S \): angular separation of the two objects
\( \Delta L \): internal optical path difference between reference and science object

Knowledge of \( B \) and measuring \( \text{OPD}_s \) and \( \Delta L \) independently,
• an image of the science object can be reconstructed (Phase referencing)
• measurement of the star separation (narrow angle astrometry)
Laser metrology for PRIMA II

Metrology system needed to monitor $\Delta L$ with accuracy of 5 nm to measure the angular distance of two stars at the 10 microarcsecond level

Proposed system by Salvade and Dandliker:

- Two heterodyne laser interferometers, one for science object and one for reference object
- Two different frequency shifts to avoid crosstalk, $f_1 = 650$ kHz, $f_2 = 450$ kHz
- Frequency offset between the two interferometers: $\Delta \nu = 80$ MHz
- Two interference signals: $\phi_1 = \frac{4\pi \nu L_1}{c}$ \quad $\phi_2 = \frac{4\pi (\nu + \Delta \nu) L_2}{c}$

where $L_1$ and $L_2$ are the internal optical path differences for the science and reference object

The value $\Delta L = L_1 - L_2$ is the interesting value for PRIMA and is restricted to 60 mm due to maximum angular distance and telescope lay-out
Laser metrology for PRIMA III

Individual measurements of $\varphi_1$ and $\varphi_2$ have disadvantages:
• simultaneous measurements are needed due to the speed of the ‘delay lines (5 mm/s)
• $\varphi_1$ and $\varphi_2$ vary fast, so integration times short
• phase noise by laser frequency fluctuations high due to large OPD (130 m)

Solution: Superheterodyne detection, i.e. measuring $\Delta\varphi = \varphi_1 - \varphi_2$, by mixing the two interference signals electronically and bandpass filtering around f1-f2.
Laser metrology for PRIMA IV

Advantages of Superheterodyne detection

• Direct measurement of differential optical path difference $\Delta L$
• The phase difference $\phi_1 - \phi_2$ varies slower than individual phases, i.e. longer integration time for phase measurement
• If the same laser is used for both individual interferometers, phase noise much lower than of the individual heterodyne signals
Metrology for future VLTI instrument: homothetic mapping

Second generation instrument for VLTI:

Wide-field of View imaging through homothetic mapping:
Input apertures inside beamcombiner equal to telescope arrangement

Monitoring and controlling in the beamcombiner:
• pupil positions (lateral and longitudinal)
• pupil scaling
• pupil rotations
• image matching
Keck Interferometer
Keck Interferometer

Keck Interferometer metrology

- Local metrology of the fast delay lines. This is implemented with a conventional heterodyne metrology system, and will be used primarily for delay-line servo control.

- End-to-end, or constant-term, metrology of the complete optical path from beam combiner to dual-star module. This metrology references the primary and secondary beam paths to identical fiducials in order to implement co-phasing and narrow-angle astrometry. The metrology will also monitor vibrations in the beam-transport optics.

- Accelerometer sensing of optics. Accelerometers on key optics not monitored by laser metrology will sense vibrations which could affect fringe visibility. Vibrations measured with the accelerometers will be fed forward to the delay lines for high-bandwidth compensation.
Keck Interferometer: Quick Facts

85m Baseline

Initial Wavelength Coverage  H and K bands
Low resolution spectrometer (lambda/d_lambda ~25)
All wavelengths available simultaneously

Fringe tracker  Faint mag limit: ~9 Kmag (initially), ~14 Kmag (late 2002)
                 Bright limit: ~3 Kmag

Adaptive Optics limit  R mag: 5 mag (bright), 13 mag (faint)

Slew and fringe acquire time  <10 minutes to switch between stars
(Includes Adaptive Optics acquisition time)

Expected Visibility err  < 5%

Special operating modes  Differential phase: March 2002
                         Nulling: June 2002

Number of interferometers  2 2.2µm combiners
                              2 10µm nulling combiners
                              1 10µm cross combiner (combines the two nullers)
DARWIN Key characteristics

- Science objectives: Planet Detection and high-resolution astrophysics

Design
- 6 optical 1.5 m telescope free flyers
- 1 central hub for beam combination
- Master satellite for data handling, Earth communication and out-of-plane interferometry motion
DARWIN metrology

Requirements:
- Baseline accuracy: $< \sim 1$ cm
- Optical path differences: $< \sim 20$ nm rms
- Telescope pointing errors: $< \sim 24$ mas rms
- Flux differences: $< 1.0 \ E-3$

Several metrology systems are defined to fulfil the requirements.
Darwin metrology systems

• **Coarse metrology:**
  – What? In and out-of-plane translation detection
  – How? RF ranging and laser goniometry or ?? => accuracy < 1cm

• **Medium metrology:**
  – What?
    • Transverse alignment of FF beams w.r.t. the Hub receiver telescopes
    • Differential drift between Hub and FF
  – How? Laser interferometer and Wide Field Camera

• **Fine metrology**
  – What?
    • OPD sensing
    • telescope pointing
  – How?
    • Laser interferometer or fringe sensor / tracker
    • Wide Field Camera
    • laser pointer for detecting tilts of FF w.r.t. Hub receiver

All these systems can be replaced by simpler and better ones!
Terrestrial Planet Finder; the US Darwin mission

<table>
<thead>
<tr>
<th>Darwin (ESA)</th>
<th>TPF (NASA)</th>
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<tbody>
<tr>
<td>- 6 FF 1.5 m diameter</td>
<td>- 4 FF 3.5 m diameter</td>
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<tr>
<td>- Baseline 25-500 m</td>
<td>- Baseline 75-1000 m</td>
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No major differences and the same science objectives makes a cooperation between ESA and NASA likely.
Space Interferometer Mission
Space Interferometer Mission Metrology characteristics

SIM requirements to achieve astrometry with 1 μarcsecond accuracy:
• relative OPL measurement accuracy of 20 picometer
• Baseline measurements in three dimensions with the metrology kite
Technology validating pre-cursor missions

ESA: SMART-2
NASA: StarLight

Similar concept of two free-flying satellites to validate a number of critical technologies for DARWIN, LISA and TPF

• laser metrology
• stellar fringe detection
• formation flying
• data control / handling
Future research

More research is needed to make all projects described technically and economically viable:

- Laser frequency stabilisation
- Optical designs
- Miniaturisation of components
- Space-qualified components
- New ideas for metrology systems
Conclusions

- Stellar interferometry will be the method of observing stars in the nearby future.

- Monitoring and controlling optical components in these instruments will need a range of existing and to be developed metrology systems, which gives an opportunity for Dutch industry to become more involved.